

IGBT in TO-263

Features

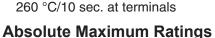
- 650V 20A, VCE(sat)(typ.) = 1.70 V@20A
- Field Stop IGBT Technology
- 10µs Short Circuit Capability
- Square RBSOA
- Positive VCE (on) Temperature Coefficient

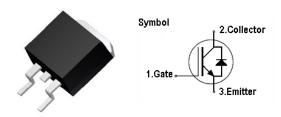
Benefits

- High Efficiency for Motor Control
- Rugged Performance
- Excellent Current Sharing in Parallel Operation

Mechanical Data

- Case: TO-263 (plastic package). Lead free; RoHS compliant
- Molding Compound Flammability Rating: UL 94 V-0
- **Terminals:** High temperature soldering guaranteed: 260 °C/10 sec. at terminals





Ordering Information

Part Number	Package	Marking
CXG20N65BS	TO-263	DXG20N65BS

Applications

RDSEMI's IGBTs offer lower losses and higher energy for application such as motor drive ,UPS, inverter and other soft switching applications.

Symbol	Parameter	Value	Units
V_{CES}	Collector-Emitter Voltage	650	V
V_{GES}	Gate-Emitter Voltage	±30	V
Ic	Continuous Collector Current (T _C =25 ℃)	40	Α
IC	Continuous Collector Current (T _C =100℃)	20	А
I _{CM}	Pulsed Collector Current (Note 1)	80	А
I _F	Diode Continuous Forward Current (T _C =100 ℃)	20	Α
I _{FM}	Diode Maximum Forward Current (Note 1)	80	А
t _{sc}	Short Circuit Withstand Time	10	us
Isc	Short Circuit Current	150	Α
P _D	Maximum Power Dissipation (T _C =25 ℃)	178	W
P_D	Maximum Power Dissipation (T _C =100℃)	71	W
TJ	Operating Junction Temperature Range	-55 to +150	${\mathbb C}$
T _{STG}	Storage Temperature Range	-55 to +150	${\mathbb C}$

Thermal Characteristics

Symbol	Parameter	Max.	Units
R _{th j-c}	Thermal Resistance, Junction to case for IGBT	0.7	°C/ W
R _{th j-c}	Thermal Resistance, Junction to case for Diode	1.5	°C/W
R _{th j-a}	Thermal Resistance, Junction to Ambient	80	°C/W



Electrical Characteristics (TC=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	650	-	-	V
I _{CES}	Collector-Emitter Leakage Current	V _{CE} = 650V, V _{GE} = 0V	-	-	250	uA
	Gate Leakage Current, Forward	V_{GE} =30V, V_{CE} = 0V	-	-	100	nA
I _{GES}	Gate Leakage Current, Reverse	V_{GE} = -30V, V_{CE} = 0V	-	-	-100	nA
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 250uA$	4.0	-	5.5	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	V_{GE} =15V, I_{C} = 20A	-	1.70		V
Qg	Total Gate Charge	V _{CC} =480V	-	79		nC
Qge	Gate-Emitter Charge	V _{GE} =15V	-	11		nC
Qgc	Gate-Collector Charge	I _C =20A	-	43		nC
t _{d(on)}	Turn-on Delay Time		-	16	-	ns
t _r	Turn-on Rise Time	V _{CC} =400V V _{GE} =15V	-	27	-	ns
t _{d(off)}	Turn-off Delay Time	I _C =20A		113	-	ns
t f	Turn-off Fall Time	R _G =10Ω Inductive Load	-	26	-	ns
Eon	Turn-on Switching Loss	T _C =25 °C	-	0.49	-	mJ
Eoff	Turn-off Switching Loss	16 20 6	-	0.31	-	mJ
C _{ies}	Input Capacitance	V _{CE} =25V	-	980	-	pF
Coes	Output Capacitance	V _{GE} =0V	-	130	-	pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz	-	60	-	pF
R _{Gint}	Integrated gate resistor	f=1MHz;Vpp=1V		2.30		Ω

Electrical Characteristics of Diode (TC=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V_{F}	Diode Forward Voltage	I _F =20A	•	2.3		V
trr	Diode Reverse Recovery Time	V _{CE} = 400V I _F = 20A	-	42		ns
Irrm	Diode peak Reverse Recovery Current	dlr/dt = 500A/us	-	7.6		Α
Qrr	Diode Reverse Recovery Charge		-	186		nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

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Fig 1. DC Collector current as a function of case

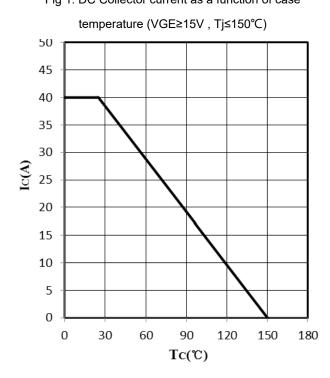


Fig 2. Power dissipation as a function of case

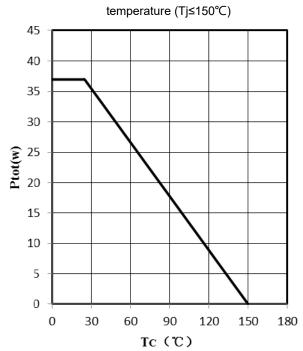


Fig 3. IGBT Forward safe operation area

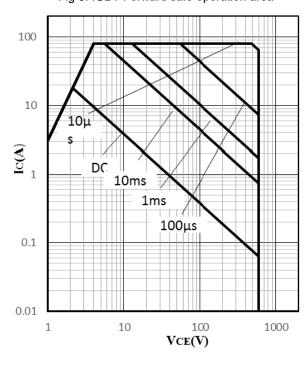


Fig 4. IGBT Reverse safe operation area

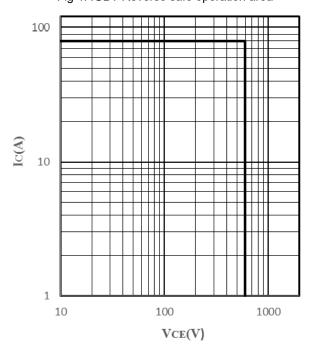




Fig 5. Typical output characteristic (Tj=25°C)

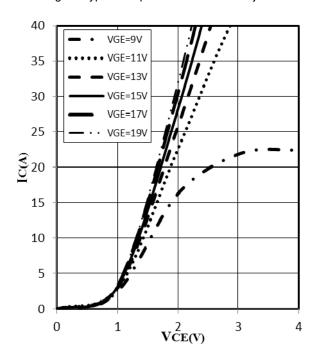


Fig 6. Typical output characteristic (Tj=125°C)

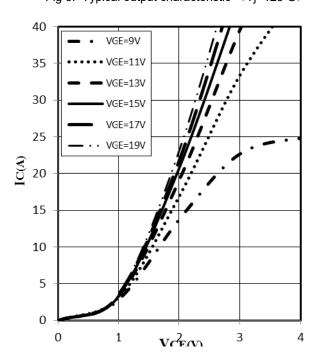


Fig 7. Typical transfer characteristic (V_{CE} =20V)

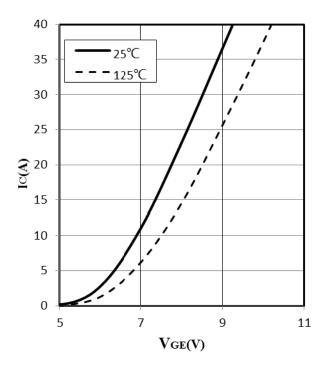


Fig 8. Typical collector-emitter saturation voltage as a function of junction temperature (VGE=15V)

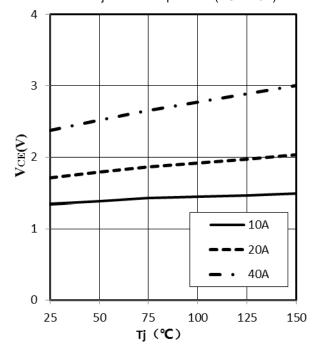
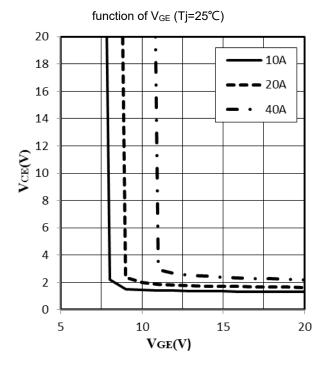




Fig 9. Typical collector-emitter saturation voltage as a



function of V_{GE} (Tj=125°C)

Fig 10. Typical collector-emitter saturation voltage as a

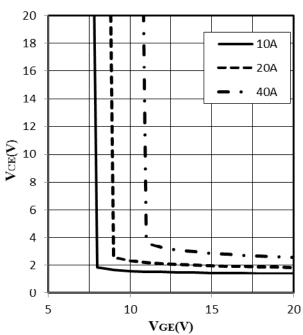
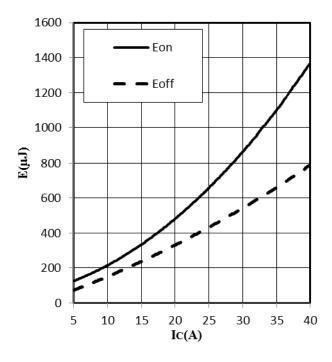


Fig 11. Typical switch energy as a function of lc (inductive load, T_j =25°C , V_{CE} =400V, V_{GE} =15V, R_G =10 Ω)

Fig 12. Typical switch time as a function of Ic (inductive load, T_j =25°C , V_{CE} =400V, V_{GE} =15V, R_G =10 Ω)



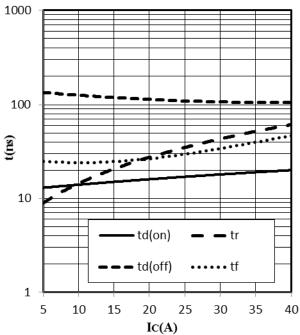




Fig 13. Typical switch energy as a function of R_G (inductive load, T_j =25°C , V_{CE} =400V, V_{GE} =15V, I_C =20A)

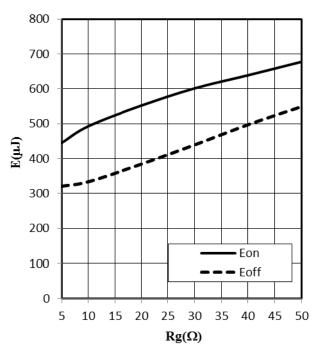


Fig 15. Typical capacitance as a function of collectoremitter voltage (V_{GE}=0V,f=1MHz)

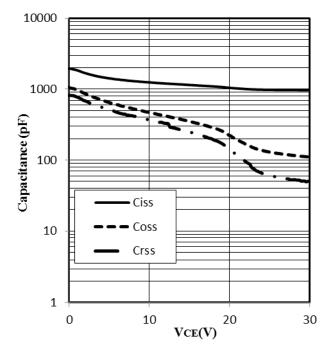


Fig 14. Typical switch time as a function of R_G (inductive load, T_j =25°C , V_{CE} =400V, V_{GE} =15V,Ic=20A)

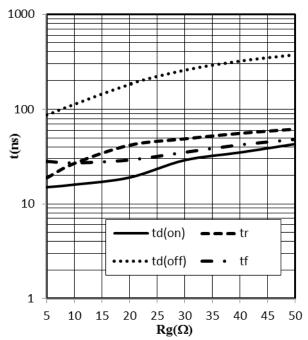


Fig 16. Typical gate charge (Ic=20A)

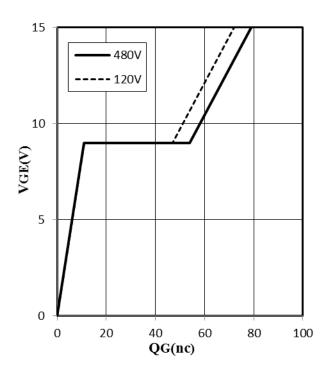




Fig 17. Typical diode forward current as a function of forward voltage

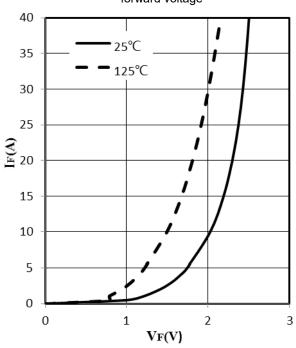


Fig 18. Typical trr as a function of dl_F/dt

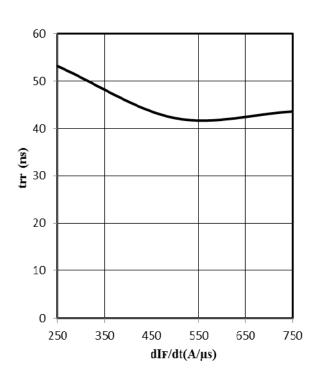


Fig 19. Typical Irrm as a function of dI_F/dt

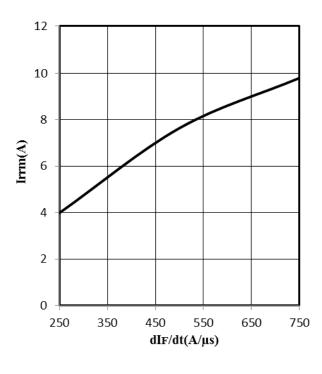
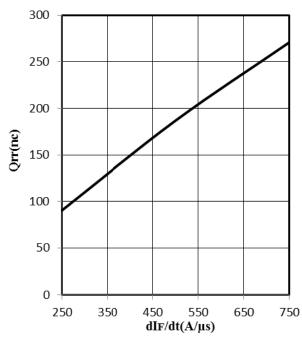


Fig 20. Typical Q_{rr} as a function of dI_F/dt





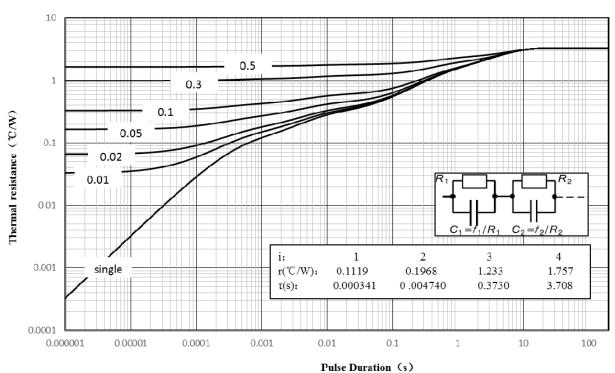
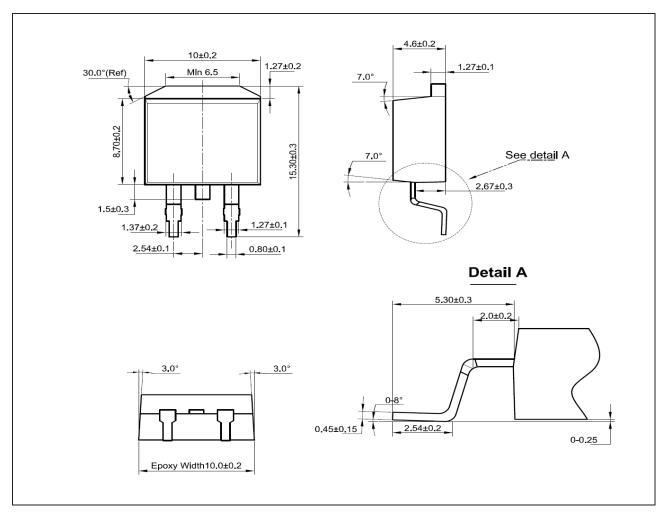


Fig 21. IGBT transient thermal resistance(D=tp/T)

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Package Dimensions



Ordering information

Order code	Package	Packaging option	Base quantity	Packaging specification
CXG20N65BS	TO-263	Tape/Reel	800pcs / Reel	EIA STD RS-481

Revision history

Date	Revision	Changes
28-May-2020	1.0	Initial release



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